Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/662,423	ITO ET AL.	
Examiner	Art Unit	
David M. Fenstermacher	3682	

	SEARCHED			
Class	Subclass	Date	Examiner	
184	6.5			
	6.22			
	6.4			
	6.6			
	104.3			
	105.1			
123	196R			
	196AB	8/2/2006	DMF	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
		-		

SEARC (INCLUDING SE	CH NOTES ARCH STRATE	EGY)
	DATE	
EAST - attached	8/2/200	06 DMF